

The Technical Association of Refractories, Japan

Certified Reference Material Series for X-ray Fluorescence Analysis of Refractories

JRRM 321 (High-Alumina Refractory)

Results of Analyses

Unit : mass%

Constituent	SiO ₂	Al ₂ O ₃	Fe ₂ O ₃	TiO ₂	MnO	CaO	MgO	Na ₂ O	K ₂ O	P ₂ O ₅	Cr ₂ O ₃	ZrO ₂	
Certified value	44.68	38.91	3.971	0.945	0.065	0.920	3.181	0.468	2.280	3.366	0.995	0.028	
Laboratories	L ₁	44.68	38.46	4.001	0.958	0.068	0.913	3.188	0.477	2.324	3.410	1.006	
	L ₂	44.85	38.84	3.964	0.922	0.065	0.923	3.151	0.471	2.160	3.354	0.988	
	L ₃	44.60	38.67	3.934	0.953	0.066	0.924	3.154	0.474	2.237	3.367	1.014	
	L ₄	44.88	38.89	3.940	0.942	0.064	0.917	3.222	0.474	2.295	3.372	0.996	
	L ₅	44.80	39.10	3.999	0.943	0.062	0.912	3.118	0.463	2.281	3.288	0.991	
	L ₆	44.62	39.30	4.010	0.954	0.064	0.944	3.175	0.462	2.284	3.429	0.988	
	L ₇	44.40	39.34	3.997	0.954	0.068	0.901	3.277	0.465	2.278	3.376	0.993	
	L ₈	44.64	38.65	3.922	0.937	0.066	0.922	3.166	0.459	2.382	3.333	0.984	
Average	\bar{X}	44.684	38.906	3.9709	0.9454	0.0654	0.9195	3.1814	0.4681	2.2801	3.3661	0.9950	0.0280
Reproducibility (within laboratory)	$S_{\bar{x}}$ $S_{(IT)}^{*1}$	0.159 0.106	0.317 0.091	0.0353 0.0177	0.0121 0.0057	0.0021 0.0009	0.0127 0.0135	0.0487 0.0191	0.0066 0.0106	0.0644 0.0277	0.0438 0.0162	0.0100 0.0065	0.0064 0.0024
Uncertainty	C (95%) ^{*2}	0.130	0.270	0.030	0.010	0.002	0.011	0.041	0.006	0.054	0.037	0.008	0.005

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

- (1) List of laboratories : Krosaki Harima Corporation, Shinagawa Refractories Co, Ltd, TYK Corporation, AGC Ceramics Co, Ltd, TOSHIBA NANOANALYSIS CORPORATION, JFE Techno-Research Corporation, CLEARIZE Co., Ltd, NIPPON STEEL TECHNOLOGY Co., Ltd
- (2) Analytical techniques : Wet chemical analysis method (ISO 21587)
- (3) Analytical values : Each value is the average of two values obtained by two measurements on different days. These analysis values are shown converted into LOI (Loss on ignition) component free values.
- (4) Outlier tests were carried out by Grubbs test. The samples rejected by Grubbs tests were discussed in view of analytical techniques and it was determined whether the outliers should be adopted or not.
- (5) Date of preparation : March, 2019

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Certified value	39.82	49.74	4.516	0.573	0.290	1.104	0.602	1.104	0.714	0.641	0.056	0.512	
Laboratories	L ₁	39.93	49.36	4.529	0.588	0.291	1.128	0.601	1.122	0.706	0.654	0.055	0.571
	L ₂	40.25	49.82	4.506	0.562	0.288	1.114	0.604	1.094	0.704	0.630	0.055	0.509
	L ₃	39.71	50.07	4.459	0.574	0.284	1.093	0.596	1.078	0.705	0.647	0.067	0.488
	L ₄	39.77	49.77	4.445	0.556	0.284	1.078	0.578	1.110	0.738	0.645	0.046	0.565
	L ₅	40.17	49.79	4.448	0.568	0.286	1.092	0.604	1.105	0.715	0.614	0.054	0.502
	L ₆	39.89	49.80	4.646	0.562	0.298	1.082	0.622	1.102	0.703	0.635	0.062	0.512
	L ₇	39.40	49.75	4.557	0.586	0.291	1.120	0.602	1.117	0.707	0.614	0.060	0.464
	L ₈	39.44	49.54	4.538	0.591	0.300	1.126	0.613	1.105	0.734	0.686	0.052	0.488
Average	\bar{X}	39.820	49.738	4.5160	0.5734	0.2902	1.1041	0.6025	1.1041	0.7140	0.6406	0.0564	0.5124
Reproducibility (within laboratory)	$S_{\bar{x}}$ $S_{(IT)}^{*1}$	0.305 0.055	0.209 0.182	0.0680 0.0256	0.0136 0.0040	0.0060 0.0038	0.0202 0.0133	0.0128 0.0058	0.0139 0.0111	0.0142 0.0097	0.0236 0.0109	0.0065 0.0015	0.0377 0.0109
Uncertainty	C (95%) ^{*2}	0.250	0.170	0.057	0.011	0.005	0.017	0.011	0.012	0.012	0.020	0.005	0.032

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

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Certified value	31.89	55.81	1.707	0.202	0.232	2.075	2.718	1.456	0.193	2.632	0.208	0.650	
Laboratories	L ₁	31.93	55.73	1.704	0.208	0.239	2.084	2.769	1.447	0.210	2.662	0.211	
	L ₂	31.95	55.90	1.713	0.190	0.228	2.086	2.691	1.445	0.173	2.657	0.218	
	L ₃	31.85	55.89	1.688	0.202	0.228	2.090	2.699	1.444	0.182	2.625	0.214	
	L ₄	31.73	55.59	1.707	0.202	0.226	2.106	2.730	1.446	0.202	2.632	0.198	
	L ₅	32.17	56.07	1.704	0.202	0.221	2.078	2.698	1.429	0.174	2.613	0.198	
	L ₆	31.97	56.01	1.718	0.198	0.234	2.023	2.730	1.480	0.196	2.540	0.213	
	L ₇	31.92	55.91	1.719	0.200	0.239	2.045	2.699	1.455	0.199	2.758	0.209	
	L ₈	31.60	55.34	1.701	0.211	0.242	2.088	2.724	1.503	0.208	2.568	0.206	
Average	\bar{X}	31.890	55.805	1.7068	0.2016	0.2321	2.0750	2.7175	1.4561	0.1930	2.6319	0.2084	0.6495
Reproducibility (within laboratory)	$S_{\bar{x}}$ $S_{(IT)}$ ^{*1}	0.169 0.085	0.242 0.094	0.0102 0.0113	0.0061 0.0048	0.0073 0.0028	0.0271 0.0125	0.0261 0.0283	0.0237 0.0338	0.0147 0.0039	0.0657 0.0230	0.0075 0.0020	0.0395 0.0241
Uncertainty	C (95%) ^{*2}	0.140	0.200	0.009	0.005	0.006	0.023	0.022	0.020	0.012	0.055	0.006	0.033

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

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Certified value	24.92	62.70	3.309	4.982	0.098	0.313	0.977	0.123	0.390	1.553	0.302	0.009	
Laboratories	L ₁	25.12	62.63	3.437	5.055	0.103	0.348	0.975	0.136	0.398	1.591	0.306	0.013
	L ₂	25.08	62.61	3.284	4.874	0.098	0.307	0.970	0.128	0.384	1.514	0.298	0.004
	L ₃	25.02	62.78	3.246	4.799	0.096	0.313	0.970	0.118	0.382	1.557	0.306	0.018
	L ₄	25.08	62.85	3.308	5.063	0.094	0.289	0.978	0.138	0.387	1.562	0.295	0.006
	L ₅	25.08	62.74	3.268	5.035	0.098	0.315	0.964	0.117	0.398	1.550	0.292	0.011
	L ₆	24.72	63.12	3.238	4.970	0.096	0.290	0.954	0.120	0.376	1.527	0.304	0.007
	L ₇	24.46	62.52	3.447	5.076	0.099	0.323	1.012	0.116	0.378	1.586	0.314	0.007
	L ₈	24.82	62.39	3.246	4.983	0.100	0.318	0.993	0.114	0.413	1.534	0.305	0.008
Average	\bar{X}	24.922	62.705	3.3092	4.9819	0.0980	0.3129	0.9770	0.1234	0.3895	1.5526	0.3025	0.0093
Reproducibility (within laboratory)	$S_{\bar{x}}$ $S_{(IT)}$ ^{*1}	0.235 0.106	0.224 0.110	0.0852 0.0166	0.0991 0.0286	0.0027 0.0021	0.0190 0.0048	0.0181 0.0082	0.0096 0.0025	0.0125 0.0108	0.0271 0.0100	0.0070 0.0049	0.0046 0.0006
Uncertainty	C (95%) ^{*2}	0.200	0.190	0.071	0.083	0.002	0.016	0.015	0.008	0.010	0.023	0.006	0.004

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

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Certified value	19.99	68.98	2.470	2.249	0.012	0.700	0.264	1.690	3.086	0.148	0.038	0.045	
Laboratories	L ₁	20.07	68.64	2.489	2.297	0.013	0.722	0.272	1.703	3.146	0.148	0.036	0.040
	L ₂	20.23	68.91	2.481	2.219	0.012	0.702	0.256	1.712	3.028	0.144	0.040	0.038
	L ₃	20.18	68.65	2.444	2.230	0.012	0.706	0.265	1.706	3.073	0.146	0.037	0.044
	L ₄	19.89	68.74	2.439	2.206	0.012	0.685	0.260	1.682	3.125	0.152	0.034	0.046
	L ₅	20.18	69.33	2.447	2.255	0.012	0.701	0.266	1.713	2.932	0.141	0.041	0.054
	L ₆	19.67	69.06	2.495	2.260	0.012	0.702	0.262	1.650	3.138	0.154	0.041	0.046
	L ₇	20.00	69.16	2.521	2.282	0.012	0.681	0.272	1.655	2.984	0.141	0.038	0.045
	L ₈	19.69	69.36	2.442	2.241	0.012	0.704	0.258	1.696	3.258	0.156	0.038	0.044
Average	\bar{X}	19.989	68.981	2.4698	2.2488	0.0121	0.7004	0.2639	1.6896	3.0855	0.1478	0.0381	0.0446
Reproducibility (within laboratory)	$S_{\bar{x}}$	0.220	0.291	0.0310	0.0310	0.0003	0.0127	0.0060	0.0250	0.1036	0.0059	0.0026	0.0047
Uncertainty	$C(95\%)^{*2}$	0.180	0.240	0.026	0.026	0.000	0.011	0.005	0.021	0.087	0.005	0.002	0.004

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

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Certified value	15.92	73.86	1.881	2.629	0.020	0.495	0.393	1.836	1.694	0.311	0.496	0.309	
Laboratories	L ₁	16.05	73.85	1.878	2.601	0.021	0.526	0.383	1.850	1.725	0.301	0.512	0.340
	L ₂	16.31	73.65	1.888	2.620	0.021	0.496	0.404	1.866	1.746	0.293	0.495	0.287
	L ₃	15.91	73.93	1.840	2.582	0.018	0.498	0.387	1.844	1.670	0.298	0.50	0.318
	L ₄	15.88	73.94	1.834	2.564	0.018	0.467	0.370	1.872	1.629	0.332	0.482	0.354
	L ₅	16.05	73.82	1.823	2.638	0.018	0.482	0.389	1.820	1.673	0.336	0.473	0.288
	L ₆	15.90	74.02	1.980	2.696	0.020	0.486	0.398	1.782	1.641	0.303	0.506	0.301
	L ₇	15.77	73.79	1.898	2.637	0.020	0.502	0.409	1.820	1.706	0.300	0.500	0.297
	L ₈	15.52	73.87	1.910	2.692	0.020	0.502	0.405	1.836	1.759	0.324	0.501	0.290
Average	\bar{X}	15.924	73.859	1.8814	2.6288	0.0195	0.4949	0.3931	1.8362	1.6936	0.3109	0.4961	0.3094
Reproducibility (within laboratory)	$S_{\bar{x}}$ $S_{(IT)}^{*1}$	0.229 0.048	0.109 0.155	0.0510 0.0150	0.0477 0.0076	0.0012 0.0010	0.0173 0.0115	0.0134 0.0051	0.0289 0.0168	0.0478 0.0201	0.0168 0.0035	0.0125 0.0080	0.0254 0.0046
Uncertainty	C (95%) ^{*2}	0.190	0.090	0.043	0.040	0.001	0.014	0.011	0.024	0.040	0.014	0.010	0.021

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Certified value	9.977	76.33	3.061	1.453	0.141	0.212	1.483	2.169	2.890	0.555	0.684	0.996	
Laboratories	L ₁	9.901	76.59	3.004	1.467	0.142	0.207	1.497	2.208	2.941	0.562	0.685	1.000
	L ₂	10.084	76.29	3.053	1.431	0.146	0.209	1.519	2.232	3.056	0.536	0.687	0.948
	L ₃	9.985	75.91	3.090	1.440	0.133	0.221	1.430	2.206	2.869	0.554	0.695	1.000
	L ₄	10.062	76.14	3.084	1.460	0.138	0.210	1.544	2.260	2.863	0.552	0.688	1.007
	L ₅	9.968	76.62	3.008	1.464	0.140	0.219	1.466	2.035	2.804	0.554	0.670	0.980
	L ₆	9.881	76.40	3.140	1.465	0.135	0.202	1.411	2.095	2.790	0.542	0.660	1.043
	L ₇	10.282	75.96	3.056	1.442	0.144	0.207	1.487	2.154	2.870	0.570	0.702	1.007
	L ₈	9.656	76.76	3.052	1.458	0.148	0.222	1.510	2.160	2.926	0.571	0.688	0.986
Average	\bar{X}	9.9774	76.334	3.0609	1.4534	0.1407	0.2121	1.4830	2.1688	2.8899	0.5551	0.6844	0.9964
Reproducibility (within laboratory)	$S_{\bar{x}}$ $S_{(IT)}^{*1}$	0.1811 0.0657	0.314 0.121	0.0444 0.0241	0.0137 0.0179	0.0052 0.0032	0.0073 0.0067	0.0450 0.0123	0.0745 0.0176	0.0846 0.0242	0.0124 0.0058	0.0136 0.0033	0.0272 0.0145
Uncertainty	C (95%) ^{*2}	0.151	0.260	0.037	0.011	0.004	0.006	0.038	0.062	0.071	0.010	0.011	0.023

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Constituent	SiO ₂	Al ₂ O ₃	Fe ₂ O ₃	TiO ₂	MnO	CaO	MgO	Na ₂ O	K ₂ O	P ₂ O ₅	Cr ₂ O ₃	ZrO ₂	
Certified value	7.058	85.86	0.207	3.362	0.187	0.108	0.056	0.605	0.104	1.973	0.103	0.003	
Laboratories	L ₁	7.092	85.80	0.196	3.358	0.191	0.104	0.056	0.632	0.111	2.032	0.102	0.001
	L ₂	7.232	85.65	0.208	3.312	0.188	0.115	0.054	0.597	0.090	1.938	0.106	0.002
	L ₃	7.200	85.83	0.207	3.336	0.182	0.106	0.056	0.587	0.098	1.962	0.105	0.004
	L ₄	6.900	85.60	0.210	3.308	0.182	0.112	0.055	0.594	0.110	1.988	0.101	0.002
	L ₅	7.101	86.07	0.206	3.374	0.183	0.103	0.056	0.593	0.103	1.953	0.105	0.003
	L ₆	6.838	86.10	0.208	3.392	0.190	0.120	0.054	0.617	0.096	1.988	0.102	0.004
	L ₇	7.155	85.80	0.217	3.455	0.189	0.096	0.056	0.597	0.109	1.954	0.099	0.003
	L ₈	6.949	86.04	0.204	3.359	0.191	0.112	0.058	0.621	0.111	1.966	0.103	0.004
Average	\bar{X}	7.0584	85.861	0.2070	3.3618	0.1870	0.1085	0.0556	0.6048	0.1035	1.9726	0.1029	0.0029
Reproducibility (within laboratory)	$S_{\bar{x}}$	0.1454	0.192	0.0059	0.0475	0.0039	0.0079	0.0012	0.0164	0.0078	0.0297	0.0023	0.0008
Uncertainty	$C(95\%)^*$	0.122	0.160	0.005	0.040	0.003	0.007	0.001	0.014	0.007	0.025	0.002	0.001

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

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- (5) Date of preparation : March, 2019

The Technical Association of Refractories, Japan

Certified Reference Material Series for X-ray Fluorescence Analysis of Refractories

JRRM 329 (High-Alumina Refractory)

Results of Analyses

Unit : mass%

Constituent	SiO ₂	Al ₂ O ₃	Fe ₂ O ₃	TiO ₂	MnO	CaO	MgO	Na ₂ O	K ₂ O	P ₂ O ₅	Cr ₂ O ₃	ZrO ₂	
Certified value	2.016	88.51	1.015	3.782	0.035	1.490	0.217	0.869	1.340	0.085	0.374	0.153	
Laboratories	L ₁	1.977	88.59	1.015	3.744	0.036	1.493	0.217	0.899	1.378	0.087	0.375	0.148
	L ₂	1.970	88.29	1.028	3.788	0.035	1.466	0.224	0.847	1.385	0.082	0.372	0.156
	L ₃	2.076	88.20	1.006	3.614	0.035	1.463	0.214	0.883	1.340	0.084	0.374	0.157
	L ₄	2.033	88.26	1.008	3.934	0.036	1.459	0.210	0.899	1.370	0.079	0.380	0.156
	L ₅	2.033	88.93	1.002	3.792	0.034	1.537	0.225	0.852	1.265	0.082	0.372	0.154
	L ₆	1.949	88.61	1.018	3.826	0.034	1.486	0.206	0.848	1.316	0.091	0.376	0.155
	L ₇	2.072	88.40	1.044	3.740	0.035	1.515	0.224	0.846	1.300	0.080	0.372	0.151
	L ₈	2.018	88.83	1.000	3.816	0.037	1.497	0.214	0.880	1.367	0.092	0.374	0.150
Average	\bar{X}	2.0160	88.514	1.0151	3.7818	0.0353	1.4895	0.2168	0.8692	1.3401	0.0846	0.3744	0.1534
Reproducibility (within laboratory)	$S_{\bar{x}}$	0.0470	0.272	0.0148	0.0908	0.0011	0.0274	0.0072	0.0232	0.0426	0.0050	0.0027	0.0033
Uncertainty	$C(95\%)^*$	0.039	0.230	0.012	0.076	0.001	0.023	0.006	0.019	0.036	0.004	0.002	0.003

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

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JRRM 330 (High-Alumina Refractory)

Results of Analyses

Unit : mass%

Constituent	SiO ₂	Al ₂ O ₃	Fe ₂ O ₃	TiO ₂	MnO	CaO	MgO	Na ₂ O	K ₂ O	P ₂ O ₅	Cr ₂ O ₃	ZrO ₂	
Certified value	0.976	92.41	0.034	1.923	0.000	0.040	1.951	0.239	0.998	0.980	0.014	0.002	
Laboratories	L ₁	0.973	92.81	0.035	1.929	0.001	0.037	1.951	0.252	1.016	0.997	0.015	0.001
	L ₂	0.984	92.36	0.035	1.848	0.000	0.050	1.958	0.235	1.004	0.964	0.016	0.000
	L ₃	0.976	92.32	0.032	1.925	0.000	0.041	1.956	0.230	0.945	0.979	0.013	0.000
	L ₄	1.002	92.44	0.036	1.908	0.000	0.048	1.964	0.259	0.972	1.022	0.014	0.001
	L ₅	0.978	92.60	0.032	1.905	0.000	0.042	1.931	0.246	0.942	0.944	0.016	0.003
	L ₆	0.928	92.82	0.038	1.942	0.000	0.026	1.926	0.236	0.979	0.980	0.016	0.003
	L ₇	1.004	92.20	0.034	1.994	0.000	0.035	1.960	0.222	1.075	0.964	0.010	0.003
	L ₈	0.964	91.75	0.032	1.936	0.001	0.042	1.965	0.231	1.052	0.990	0.013	0.002
Average	\bar{X}	0.9761	92.412	0.0342	1.9234	0.0002	0.0400	1.9514	0.2389	0.9981	0.9800	0.0141	0.0016
Reproducibility (within laboratory)	$S_{\bar{x}}$	0.0239	0.349	0.0023	0.0410	0.0003	0.0076	0.0146	0.0122	0.0481	0.0239	0.0021	0.0009
Uncertainty	$C(95\%)^*$	0.020	0.290	0.002	0.034	0.000	0.006	0.012	0.010	0.040	0.020	0.002	0.001

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

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Constituent	SiO ₂	Al ₂ O ₃	Fe ₂ O ₃	TiO ₂	MnO	CaO	MgO	Na ₂ O	K ₂ O	P ₂ O ₅	Cr ₂ O ₃	ZrO ₂	
Certified value	0.230	99.04	0.114	0.010	0.002	0.035	0.024	0.289	0.122	0.085	0.006	0.041	
Laboratories	L ₁	0.216	99.06	0.110	0.010	0.002	0.032	0.025	0.289	0.130	0.084	0.006	0.035
	L ₂	0.226	99.03	0.122	0.008	0.002	0.039	0.027	0.287	0.110	0.092	0.007	0.048
	L ₃	0.216	99.04	0.120	0.010	0.001	0.036	0.023	0.294	0.128	0.082	0.006	0.040
	L ₄	0.218	99.07	0.096	0.009	0.002	0.039	0.026	0.284	0.118	0.088	0.007	0.041
	L ₅	0.241	99.07	0.109	0.010	0.002	0.034	0.024	0.287	0.114	0.081	0.006	0.027
	L ₆	0.234	99.01	0.114	0.012	0.001	0.034	0.021	0.294	0.129	0.090	0.006	0.057
	L ₇	0.250	99.03	0.124	0.011	0.001	0.035	0.026	0.277	0.115	0.082	0.006	0.048
	L ₈	0.236	99.03	0.118	0.010	0.002	0.034	0.024	0.297	0.130	0.082	0.006	0.034
Average	\bar{X}	0.2296	99.042	0.1141	0.0100	0.0016	0.0354	0.0245	0.2886	0.1218	0.0851	0.0062	0.0412
Reproducibility (within laboratory)	$S_{\bar{x}}$ $S_{(IT)}^{*1}$	0.0126 0.0059	0.022 0.009	0.0091 0.0025	0.0011 0.0007	0.0005 0.0005	0.0024 0.0023	0.0019 0.0010	0.0064 0.0040	0.0081 0.0042	0.0042 0.0040	0.0005 0.0000	0.0096 0.0012
Uncertainty	C (95%) ^{*2}	0.011	0.020	0.008	0.001	0.000	0.002	0.002	0.005	0.007	0.004	0.000	0.008

(Note) *1 $S_{\bar{x}}$ is intermediate precision without a time condition.*2 The half-width confidence interval C (95%) = $t_{\ell-1, 0.05} \times S_{\bar{x}} / \sqrt{\ell}$ (ℓ = number of laboratories)

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Certified value	0.003	99.99	0.000	0.000	0.000	0.001	0.001	0.003	0.000	0.003	0.000	0.000
Laboratories	L ₁	0.004	99.99	0.000	0.000	0.003	0.005	0.000	0.000	0.000	0.000	0.000
	L ₂	0.000	99.98	0.000	0.000	0.001	0.004	0.006	0.002	0.004	0.000	0.000
	L ₃	0.000	100.00	0.000	0.000	0.000	0.002	0.000	0.000	0.000	0.000	0.000
	L ₄	0.006	99.98	0.001	0.000	0.000	0.004	0.000	0.006	0.000	0.004	0.000
	L ₅	0.008	99.98	0.000	0.000	0.000	0.000	0.003	0.000	0.002	0.000	0.002
	L ₆	0.002	99.98	0.000	0.000	0.000	0.000	0.008	0.001	0.010	0.000	0.000
	L ₇	0.003	99.99	0.000	0.000	0.000	0.000	0.002	0.000	0.001	0.000	0.000
	L ₈	0.003	100.00	0.000	0.000	0.000	0.000	0.002	0.000	0.000	0.000	0.000
Average	\bar{X}	0.0032	99.988	0.0001	0.0000	0.0010	0.0014	0.0034	0.0004	0.0026	0.0000	0.0005
Reproducibility (within laboratory)	$S_{\bar{x}}$	0.0027	0.008	0.0004	0.0000	0.0015	0.0019	0.0029	0.0006	0.0035	0.0002	0.0011
Uncertainty	$C(95\%)^*$	0.002	0.010	0.000	0.000	0.001	0.002	0.003	0.001	0.003	0.000	0.001

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